


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588229	<b>Applicant(s)/Patent Under Reexamination</b>  ZENG ET AL.
	<b>Examiner</b>  Tae H Yoon	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
523	116	4/5/08	/TY/
433	228.1	4/5/08	/TY/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, INventor search	4/5/08, 4/6/08	/TY/
EAST	10/28/08	/TY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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